Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ($L^2-\pi$ -MOSV)

2SK2266

Chopper Regulator, DC-DC Converter and Motor Drive **Applications**

• 4 V gate drive

• Low drain-source ON resistance $: R_{DS}(ON) = 22 \text{ m}\Omega \text{ (typ.)}$ • High forward transfer admittance $|Y_{fs}| = 27 \text{ S (typ.)}$ • Low leakage current $: I_{DSS} = 100 \,\mu\text{A} \,(\text{max}) \,(V_{DS} = 60 \,\text{V})$

Enhancement-mode : $V_{th} = 0.8 \sim 2.0 \text{ V (VDS} = 10 \text{ V, ID} = 1 \text{ mA)}$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	60	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	60	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	45	А	
	Pulse (Note 1)	I _{DP}	180	A	
Drain power dissipatio	n (Tc = 25°C)	P _D	65	W	
Single pulse avalanch	e energy (Note 2)	E _{AS}	246	mJ	
Avalanche current		I _{AR}	45	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	6.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.92	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

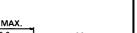
Note 1: Please use devices on condition that the channel temperature is

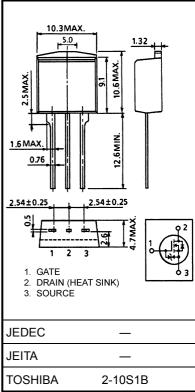
Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 165 μ H, RG = 25 Ω , I_{AR} = 45 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

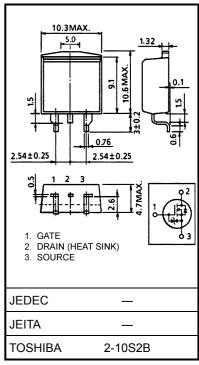
This transistor is an electrostatic sensitive device.

Please handle with caution.





Weight: 1.5 g (typ.)



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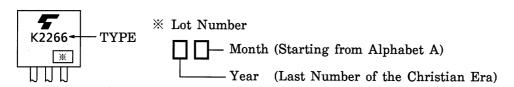
Electrical Characteristics (Ta = 25°C)

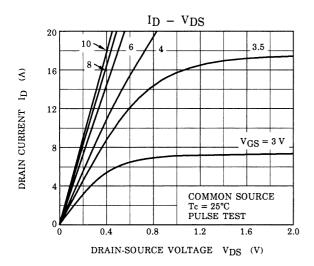
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ	
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	_	_	100	μΑ	
Drain–source br voltage	eakdown	V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	60	_	_	V	
Gate threshold v	/oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	8.0	_	2.0	V	
Drain-source ON resistance		R _{DS} (ON)	V _{GS} = 4 V, I _D = 15 A	_	40	55	mΩ	
			V _{GS} = 10 V, I _D = 25 A	_	22	30		
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 25 A	15	27	_	S	
Input capacitano	ce	C _{iss}		_	1800	_		
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	350	_	pF	
Output capacitance		Coss		_	900	_		
Switching time	Rise time	t _r	V_{GS} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT} V_{OUT}	_	20	_		
	Turn-on time	t _{on}		_	30	_	- ns	
	Fall time	t _f		_	40	_		
	Turn–off time	t _{off}	$V_{DD} = 30V$ Duty $\leq 1\%$, $t_W = 10 \mu s$		130	_		
Total gate charge (Gate–source plus gate–drain)		Qg			60			
Gate-source charge		Q _{gs}	$V_{DD} \approx 48 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 45 \text{ A}$		40	_	nC	
Gate-drain ("miller") charge		Q _{gd}			20	_		

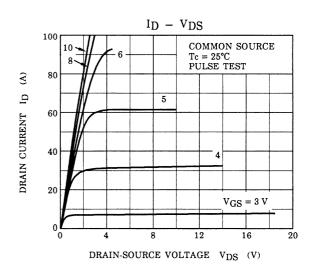
Source-Drain Ratings and Characteristics (Ta = 25°C)

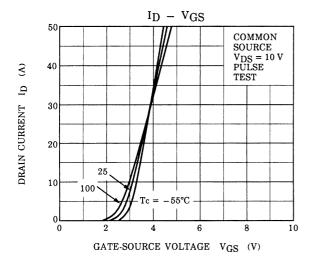
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	45	Α
Pulse drain reverse current (Note 1)	I _{DRP}		_	_	180	Α
Forward voltage (diode)	V_{DSF}	I _{DR} = 45 A, V _{GS} = 0 V	_	_	-1.8	V
Reverse recovery time	t _{rr}	I_{DR} = 45 A, V_{GS} = 0 V, dI_{DR} / dt = 50 A / μ s	_	90	_	ns
Reverse recovery charge	Q _{rr}		_	0.1	_	μC

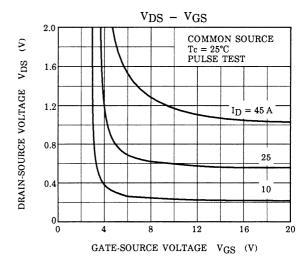
Marking

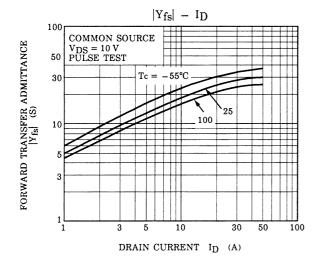


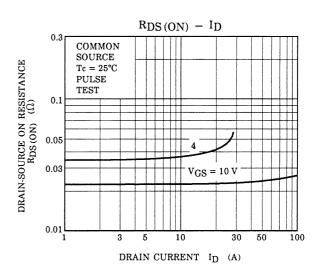




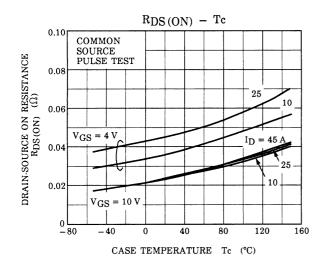


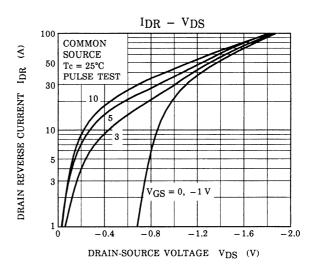


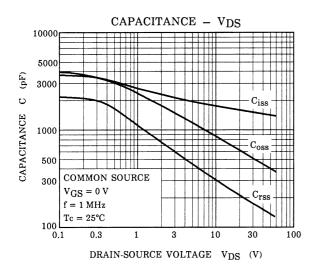


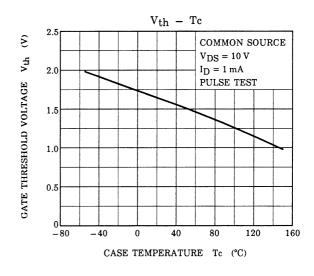


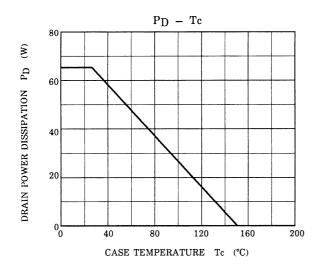
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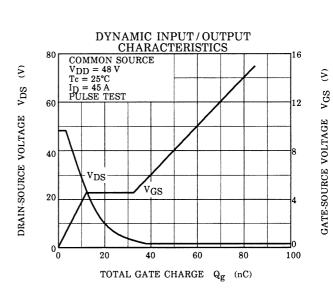




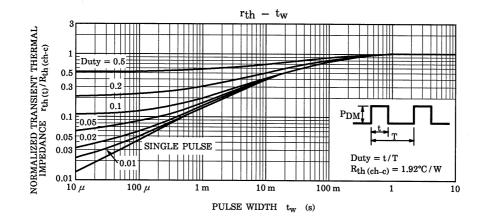


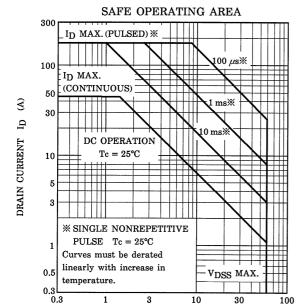




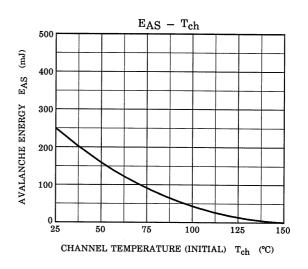


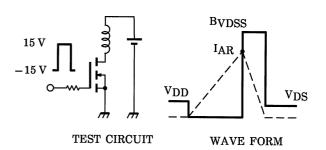
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DRAIN-SOURCE VOLTAGE V_{DS} (V)





$$\begin{aligned} R_G &= 25 \ \Omega \\ V_{DD} &= 25 \ V, \ L = 165 \ \mu H \end{aligned} \qquad EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

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